

Brammer Standard Company, Inc.

# Certificate of Analysis

BS CC-26

## Chill-cast Iron Reference Material

	Certified Value <sup>1,2</sup>	Estimate of Uncertainty <sup>3</sup>		Certified Value <sup>1</sup>	Estimate of Uncertainty <sup>3</sup>
Analysis listed as percent by weight					
<b>C</b>	<b>3.38</b>	0.03	<b>La</b>	<b>0.045</b>	0.004
<b>Mn</b>	<b>0.115</b>	0.005	<b>Mg</b>	<b>0.045</b>	0.002
<b>P</b>	<b>0.005</b>	0.001	<b>Nb</b>	<b>&lt;0.003</b>	
<b>S</b>	<b>0.002</b>	0.0008	<b>Pb</b>	<b>&lt;0.002</b>	
<b>Si</b>	<b>0.63</b>	0.01	<b>Sb</b>	<b>0.003</b>	0.0005
<b>Cu</b>	<b>0.76</b>	0.015	<b>V</b>	<b>&lt;0.003</b>	
<b>Ni</b>	<b>1.02</b>	0.02	<b>W</b>	<b>&lt;0.01</b>	
<b>Cr</b>	<b>0.016</b>	0.003	<b>Zr</b>	<b>&lt;0.002</b>	
<b>Mo</b>	<b>0.42</b>	0.01	Provisional values		
<b>Al</b>	<b>0.009</b>	0.0015	<b>Bi</b>	(0.001)	
<b>As</b>	<b>0.017</b>	0.003	<b>N</b>	(0.008)	
<b>B</b>	<b>0.0045</b>	0.0003	<b>Te</b>	(0.004)	
<b>Ce</b>	<b>0.065</b>	0.006	<b>Ti</b>	(0.001)	
<b>Co</b>	<b>0.043</b>	0.002	<b>Sn</b>	(0.002)	

<sup>1</sup> The certified value listed is the present best estimate of the true value based on the results of an interlaboratory testing program.

<sup>2</sup> Data in parentheses are not certified and are provided for information only.

<sup>3</sup> The uncertainties listed are based on value judgments of the material inhomogeneity and the 95% confidence interval. The half-width confidence interval C(95%) is shown on page 2.

See reverse side for more information.

**Certificate Number CC26-020700p1**

**Brammer Standard Company, Inc., 14603 Benfer Road, Houston, TX 77069-2895**  
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Analysis	*	C	* Mn	* P	* S	* Si	* Cu	* Ni	* Cr	* Mo
1	H	3.35	N 0.110	C 0.004	H 0.0007	C 0.616	C 0.74	B 0.989	C 0.012	C 0.405
2	H	3.353	N 0.112	C 0.004	H 0.0008	J 0.618	B 0.75	X 0.9961	C 0.012	Z 0.405
3	A	3.357	C 0.112	P1 0.0042	H 0.0016	C 0.62	C 0.752	C 1.003	C 0.013	C 0.406
4	H	3.358	C 0.112	C 0.0049	H 0.0021	J 0.627	C 0.76	C 1.01	C 0.0138	C 0.410
5	H	3.36	C 0.113	B 0.005	H 0.0023	E 0.63	C 0.76	C 1.02	C 0.014	W 0.412
6	H	3.36	C 0.114	C 0.0055	H 0.0024	J 0.636	R2 0.764	X1 1.02	C 0.015	A 0.414
7	H	3.3742	E 0.115	P1 0.0055	B 0.0025	J 0.639	R 0.769	C 1.03	B 0.016	C 0.42
8	H	3.38	N 0.1157	C 0.00556	H 0.0026	C 0.64	C 0.770	E 1.030	A 0.016	C 0.42
9	H	3.39	A 0.118	C 0.0056	A 0.0029	E 0.64	E 0.773	A 1.042	Z 0.018	B 0.423
10	H	3.430	C 0.122	C 0.0059	H 0.003	A 0.640	A 0.782	S 1.045	C 0.0183	C 0.43
11	H	3.43	B 0.124	A 0.006				C 1.05	M1 0.020	C 0.430
12			A 0.0069					E 0.0200		
Average		3.377	0.1152	0.0053	0.0021	0.631	0.762	1.021	0.0157	0.416
Std Dev		0.029	0.0044	0.0009	0.0008	0.010	0.012	0.020	0.0029	0.009
Certified		3.38	0.115	0.005	0.002	0.63	0.76	1.02	0.016	0.42
t		2.2281	2.2281	2.201	2.2622	2.2622	2.2622	2.2281	2.201	2.2281
C (95%)		0.020	0.0030	0.0006	0.0006	0.007	0.009	0.014	0.0018	0.006

Analysis	Al	As	B	Ce	Co	La	Mg	Nb	Pb
1	A 0.007	B 0.013	T 0.0040	B 0.055	AA 0.0403	C 0.041	A 0.043	C <0.0005	EE <0.0002
2	C 0.0070	Z 0.0147	C 0.0040	C 0.060	C 0.041	C 0.041	E 0.0431	C <0.002	EE <0.0002
3	C 0.008	D 0.0149	C 0.0043	Z 0.062	C 0.0419	C 0.0414	B 0.0437	C <0.002	C 0.00010
4	C 0.0082	C 0.0150	T 0.0044	CM 0.0662	Z 0.0420	C 0.042	E 0.0440	C <0.002	C 0.0001
5	C 0.009	C 0.015	A 0.0045	C 0.0664	A 0.0423	CM 0.0430	E 0.045	IC 0.00010	C 0.0002
6	C 0.009	C 0.016	B 0.00458	C 0.0693	C 0.0430	Z 0.0456	C 0.045	CM 0.00030	G 0.0004
7	C 0.0098	C 0.016	CE 0.0046	C 0.072	C 0.043	C 0.0478	CM 0.0468	C 0.0010	A 0.001
8	AA 0.01047	B 0.0198	CE 0.0046	C 0.072	C 0.043	B 0.049	C 0.047	C 0.0015	SW 0.0012
9	B 0.0105	N1 0.0204	C 0.0049		C 0.043	C 0.051	C 0.047	A 0.002	
10	C 0.0107	N2 0.0208	C 0.0049		B 0.0435		C 0.047		
11		C 0.0210			E 0.0450		C 0.0481		
12					C 0.0458				
Average	0.0090	0.0170	0.00448	0.0654	0.0429	0.0446	0.0454		
Std Dev	0.0014	0.0029	0.00031	0.0060	0.0017	0.0038	0.0018		
Certified	0.009	0.017	0.0045	0.065	0.043	0.045	0.045	<0.003	<0.002
t	2.2622	2.2281	2.2622	2.3646	2.201	2.306	2.2281		
C (95%)	0.0010	0.0020	0.00023	0.0050	0.0011	0.0029	0.0012		

Analysis	Sb	V	W	Zr	Bi	N	Te	Ti	Sn
1	Z 0.0029	AA <0.0005	C <0.002	C <0.002	G 0.0006	V 0.0079	C 0.002	C 0.0002	C 0.0006
2	C 0.0030	C <0.002	C <0.002	C <0.002	B 0.001	V 0.0079	B 0.002	C 0.0003	C 0.0010
3	A 0.003	C <0.002	C <0.002	C <0.002		V 0.00872	F 0.002	A 0.0005	A 0.001
4	C 0.003	B 0.0009	Z 0.0017	C 0.0002			C 0.003	C 0.001	C 0.001
5	C 0.003	C 0.0012	C 0.0019	C 0.0004			C 0.004	AA 0.0010	T1 0.0013
6	AA 0.00307	C 0.0013	C 0.002	C 0.0005			AA 0.00412	C 0.001	C 0.002
7	C 0.0033	C 0.0014	B 0.003	B 0.001			C 0.0047	CM 0.0011	B 0.0028
8	S1 0.0038	C 0.0015	C 0.005	CM 0.00146			EE 0.0049	C 0.0012	C 0.003
9	F 0.0041	C 0.002	C 0.0058				EE 0.0049	B 0.0014	AA 0.00305
10		A 0.0028					CM 0.0064	C 0.0015	C 0.004
Average	0.0032				0.0008	0.0082	0.0039	0.0009	0.0020
Std Dev	0.0004				0.0003	0.0005	0.0016	0.0004	0.0012
Certified	0.003	<0.003	<0.01	<0.002	(0.001)	(0.008)	(0.004)	(0.001)	(0.002)
t	2.306				12.706	4.3027	2.2622	2.2622	2.2622
C (95%)	0.0003				0.00254	0.0012	0.0012	0.0003	0.0008

\* Methods of analysis listed on page 3.

Data in parentheses are not certified but are provided for information only.  
Data listed as mass fraction expressed as percent.

$C(95\%) = (t \times sd) / \sqrt{n}$  The half-width confidence interval, where  $t$  is the appropriate Student's  $t$  value,  $sd$  is the interlaboratory standard deviation, and  $n$  is the number of acceptable mean values. For further information regarding the confidence interval for the certified value see ISO Guide 35:1989 section 4.

**Methods of analysis**

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Code	Element	Method
A	various	AES - Optical Emission - Glow Discharge
AA	various	AAS - Flame Atomic Absorption Spectrometry - standard addition method
B	various	AES - Optical Emission - Spark Source
C	various	AES - Inductively Coupled Plasma
CE	B	AES - Inductively Coupled Plasma after solvent extraction
CM	various	AES - Inductively Coupled Plasma Mass Spectrometry
D	various	AES- Inductively Coupled Plasma after hydride generation
E	various	AAS - Flame Atomic Absorption Spectrometry
EE	Pb, Te	AAS - Flame Atomic Absorption Spectrometry after solvent extraction
F	various	AAS - Flame Atomic Absorption Spectrometry after hydride generation
G	various	AAS - Electro-thermic atomization - graphite furnace
H	C, S	Combustion-Infrared Absorption (ASTM E 1019)
IC	Nb	Ion Chromotography
J	Si	Gravimetry, with perchloric acid
M1	Cr	Titration, peroxidisulphate oxidation
N	Mn	MAS - periodate oxidation
N1	As	MAS - Standard addition method
N2	As	MAS - arsenic-bismuth-molybdenumblue
P	P	MAS - molybdivanadophosphoric acid
P1	P	MAS - bismuth phosphorus molybdenum blue
R	Cu	MAS - tetraethylthiuram disulphide
R2	Cu	MAS - bis-cyclohexanone oxalyldihydrazone
S	Ni	MAS - diacetyldioxime, iodine
S1	Sb	MAS - malachite green benzene extraction
SW	Pb	Square-wave polarographic
T	B	MAS - distillation, curcumine
T1	Sn	MAS - Phenylfluorone
V	N	Inert gas Fusion Method (ASTM E 1019)
W	Mo	MAS - thiocyanate
X	Ni	Gravimetric - dimethylglyoxime
X1	Ni	MAS - dimethylglyoxime
Z	various	INAA - Instrumental Neutron Activation Analysis

AES = Atomic Emission Spectrometry

MAS = Molecular Absorption Spectrometry (photometric - spectrophotometer methods)

**Co-operating Laboratories:** The co-operating laboratories were:**Laboratory**

ANAREM, Prague, Czech Republic  
 AK Steel Research, Middletown, Ohio  
 Brammer Standard Co., Inc., Houston, Texas  
 China National Analysis Center for Iron and Steel, Beijing, China  
 Crucible Specialty Steel, Syracuse, New York  
 J. Dirats and Co., Inc., Westfield, Massachusetts  
 IMR Test Labs, Lansing, New York  
 LECO Corporation, St. Joseph, Michigan  
 Shiva Technologies, Inc., Syracuse, New York  
 Shiva Analyticals (India) Ltd., Hoskote, Bangalore, India  
 VHG Laboratories, Inc., Manchester, New Hampshire

**Laboratory contact**

Karel Bičovský  
 Howard Vail  
 Richard P. Beaumont  
 Prof. Wang Haizhou  
 William Mastroe  
 Eric E. Dirats  
 Timothy J. McGrady and Terence C. O'Brien  
 Dennis Lawrenz  
 Don Shuman  
 Dr. T. V. Ramakrishna  
 Julie M. McIntosh

**Certification Process:** The requirements of ISO Guide 31, ISO Guide 34, ISO Guide 35, and ASTM Standard Guides E 1724 and E 1831 were followed for the preparation of this reference material and certificate of analysis. This is a reference material as defined by ISO Guide 30.

**Analysis:** Chemical analyses were made on chips prepared by a lathe from the certified portion of the discs in accordance with ASTM Standard Practice E 1806. The laboratories participating in the testing normally followed the requirements of ISO Guide 25. The individual values listed on page 2 are the average of each analyst's results. Methods of analysis used were a combination of ASTM Standard Test Methods E 350 and E 1019 plus additional ICP and AA spectrometric methods.

**Outliers:** Some outlying data was excluded from the data listed on page 2 due to technical assessment of the cooperating laboratories and statistical evaluation.

**Traceability:** The following Certified Reference Materials were used to validate the analytical data listed on page 2: NIST SRM 5L, 7f, 338, 363, 364, CC1173, 1761, 2166, C2423, C2424a, C2425; ECRM 471-1, 480-1, 481-1; CKD 215, 235, 238A, 239A, 241 - 249; CMSI 1530, 1533, 1551.

**Homogeneity:** This Reference Material was tested for homogeneity using ASTM Standard Method E 826 and found acceptable. It was also examined by optical emission spectrometry using ASTM Standard Test Method E 1999 and found to be compatible with the following Certified Reference Materials: NIST SRM 1141A, C2424A, C2425.

**Validity statement:** ISO Guide 31 requires that a validity period statement be included in the certificate of analysis. This Reference Material is valid for 20 years from the certificate date.

**Source:** This material was melted and cast by American Centrifugal, Birmingham, Alabama, using an electric arc furnace. It was chill-cast into a mold on a copper chill-plate producing all discs simultaneously.

**Description and use:** This Reference Material is in the form of a disc, approximately 32 mm in diameter and 17 mm thick. It is intended for use in optical emission and x-ray spectrometric methods of analysis.

**Certified area:** The area certified of each disc is the portion extending upward 10 mm from the larger diameter surface.

**NOTE:** Shrinkage cavities may appear in the top portion of some discs. These cavities are normal and will not affect the certified portion of the disc.

**CAUTION:** The high magnesium content may interfere with proper sparking on an optical emission spectrometer. An increase in the preburn time may be required for proper spark excitation of the disc.

**Sample Preparation:** For best analytical results, use the same method for preparing the analytical surface on all reference materials as you use for production specimens. Avoid overheating the disc during surface preparation.

**Certificate Number:** The unique identification number for this certificate of analysis is CC26-020700-px, where x indicates the page number. Refer to future Brammer Standard Company catalogs for information on any revisions to this or other Brammer Standard reference materials. You may also obtain information on revisions of certificates from the internet at [brammerstandard.com](http://brammerstandard.com).

**Safety Notice:** A Material Safety Data Sheet (MSDS) is not required for this material. This material will not release or otherwise result in exposure to a hazardous chemical, under normal conditions of use. Inquiries concerning this Reference Material should be directed to:

Brammer Standard Co., Inc.  
14603 Benfer Road  
Houston, Texas 77069-2895 USA

Phone: (281) 440-9396  
Fax: (281) 440-4432

Certified by: \_\_\_\_\_ on February 7, 2000.  
G. R. Brammer

**Certificate Number CC26-020700p4**

**By Certificate Number 10539, the Quality System of Brammer Standard Company, Inc., is registered to ISO 9002:1994 by National Quality Assurance, U.S.A.**

**Brammer Standard Company's Chemical Laboratory is accredited to ISO Guide 25 by A2LA.  
(Certificate Number 656.01)**

## **References:**

*ASTM documents available from ASTM, 100 Barr Harbor Drive, West Conshohocken, PA 19428-2959,  
Telephone: 610-832-9500 Fax: 610-832-9555 e-mail: service@astm.org Website: www.astm.org*

E 350 - 90 Standard Test Methods for Chemical Analysis of Carbon Steel, Low-Alloy Steel, Silicon Electrical Steel, Ingot Iron, and Wrought Iron

E 826 - 85 (Reapproved 1990) Standard Practice for Testing Homogeneity of Materials for the Development of Reference Materials

E 1019 - 93 Standard Test Methods for Determination of Carbon, Sulfur, Nitrogen, and Oxygen in Steel and in Iron, Nickel, and Cobalt Alloys

E 1724 - 95 Standard Guide for Testing and Certification of Metal and Metal-Related Reference Materials

E 1806 - 96 Standard Practice for Sampling Steel and Iron for Determination of Chemical Composition

E 1831 - 96 Standard Guide for Preparing Certificates for Reference Materials Relating to Chemical Composition of Metals, Ores, and Related Materials.

E 1999 - 99 Standard Test Method for Analysis of Cast Iron Using Optical Emission Spectrometry

*ISO Guides available from American National Standards Institute, 11 West 42nd St., 13th Floor, New York, NY 10036.*

ISO Guide 25 (Third edition, 1990), General requirements for the competence of calibration and testing laboratories.

ISO Guide 30 (Second edition, 1991), Terms and definitions used in connection with reference materials.

ISO Guide 31 (First edition, 1981), Contents of certificates of reference materials.

ISO Guide 33 (First edition, 1989), Uses of certified reference materials.

ISO Guide 34 (First edition, 1996), Quality system guidelines for the production of reference materials.

ISO Guide 35 (Second edition, 1989), Certification of reference materials - General and statistical principles.

*Other useful documents available from NIST, U.S. Department of Commerce, Gaithersburg, MD 20899.*

NIST Special Publication 260-100, Handbook for SRM Users

NIST Special Publication 829, Use of NIST Standard Reference Materials for Decisions on Performance of Analytical Chemical Methods and Laboratories

**Certificate Number CC26-020700p5**